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8.13-14 Experimental Physics I & II "Junior Lab"  
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# PRIMER ON ERRORS

## 8.13 U.Becker

-   Random & Systematic Errors
-   Distribution of random errors
-   Binomial, Poisson, Gaussian
-   Poisson  $\leftrightarrow$  Gaussian relation
-   Propagation of Errors
-   Fits -

Read Bevington ch. 1-4

- **No measurement has infinite accuracy or precision”**
- *K.F.Gauss:*
- *“Experimental physics numbers must have errors and dimension.”*
- $G = (6.67310 \pm 0.00010)[\text{m}^3 \text{kg}^{-1} \text{s}^{-2}]$
- **Errors = deviations from Truth** (unknown, but approached)

**Large error:** Result is insignificant.

**Small error:** Good measurement, it will test theories.

**Blunders :** **no,no,** – repeat on Fridays correctly.

**Random Errors** or “statistical” - independent, repeated measurements give (slightly) different results

**Systematic Errors** “in the system”, DVM 2% low,...  
correct if you can, otherwise quote separate

## Systematic error: inherent to the system or environment

Example:

Measure g with a pendulum:

$$T = 2\pi\sqrt{\frac{l}{g}}$$

neglect m of thread)

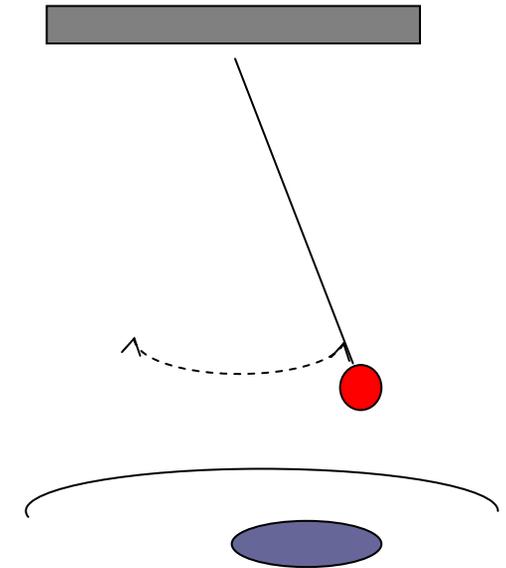
equipment (accuracy of scale, watch)

environment (wind, big mass in basement)

thermal expansion t

1. correct by  $l=l_0(1+\alpha t)$  if t known or

2. give sys.error  $\Delta_t$  from est. range of t.



large M below earth

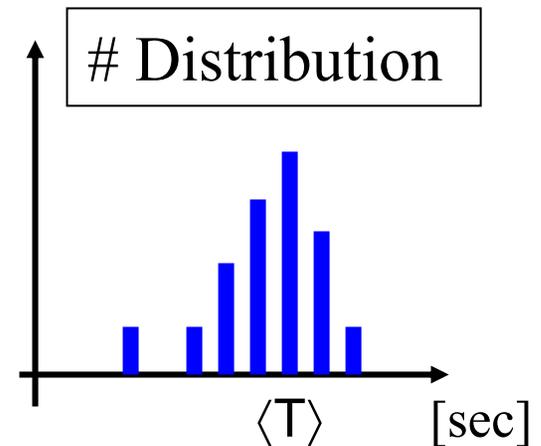
⇒ **limits ACCURACY** (=closeness to truth)

## Random (statistic) error

example:

measure period  $T$  of the pendulum several times:

measurements of  $T$  jitter around “truth”.  
 $\langle T \rangle$  improves with  $N$  measurements,  
if they are **independent**.



Statistics  $N$ :

$\Rightarrow$  **limits PRECISION** , but  $\lim(N \rightarrow \infty) = \text{truth}$

Evaluate:  $g = (l \pm \sigma_l) \{2\pi / (T \pm \sigma_T)\}^2 = 9,809 \pm ??$

To find the statistical and systematic errors of  $g$ , we need error propagation (later) and do it separately- for statistical and for systematic errors. Let's say we found:

$$g = (9.80913 \pm .007_{\text{stat}} \pm .011_{\text{sys}}) \text{m/s}^2$$

↑ nonsense digits

Compare to the “accepted value”:

([Physics.nist.gov/physRefData/contents.html](http://Physics.nist.gov/physRefData/contents.html)) gives ‘global value’

$$g = 9.80665 \pm (0) \quad \text{by definition !!}$$

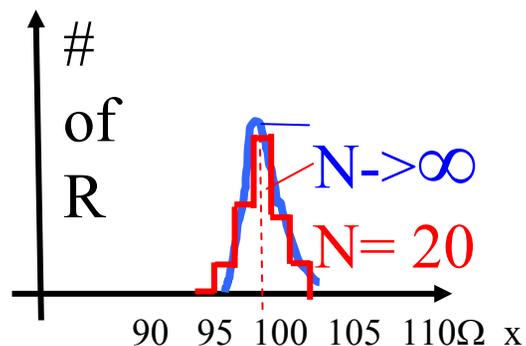
⇒ **conclusion: OK within (our) errors**

## Distribution of Measurements with Random Error:

Limit  $N \rightarrow \infty$  Parent Distribution.

Measure resistors N times:  
 manufacture  $100\Omega \pm 5\%$   
 DVM accurate to  $\pm 1\%$   
 contact resistance  $\pm 0.2\Omega$

INDEPENDENT !!!



	N measured samples	Parent distribution
Graph	histogram	smooth curve
Average -> Mean	$\langle x \rangle = \frac{1}{N} \sum_{i=1}^N x_i$	$\mu = \lim_{N \rightarrow \infty} \left( \frac{1}{N} \sum_{i=1}^N x_i \right)$
Variance -> standard deviation	$s_x^2 = \frac{1}{N-1} \sum_{i=1}^N (x_i - \langle x \rangle)^2$	$\sigma_x^2 = \lim_{N \rightarrow \infty} \left( \frac{1}{N-1} \sum_{i=1}^N (x_i - \mu)^2 \right)$
Result $\pm$ error	$\langle x \rangle \pm s_x / \sqrt{N}$	$\mu \pm 0$

# Famous Probability Distributions:

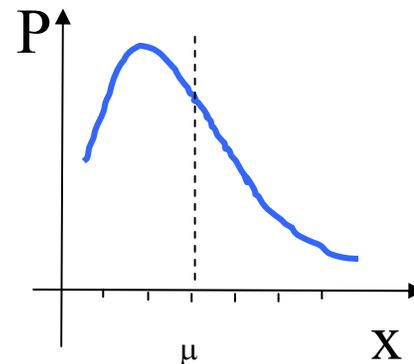
Binomial: Yes(Head):  $p$     No(Tail):  $q = 1-p$

$x$  heads in  $n$  trials:  $p^x q^{n-x}$  for pppppppp qqqqq seq.,  
There are  $\binom{x}{n} = \frac{n!}{x!(n-x)!}$  permutations, so that:

$$P(x:n,p) = \frac{n!}{x!(n-x)!} p^x (1-p)^{n-x}$$

$$\text{mean} = n \cdot p =: \mu$$

$$\text{variance} = \sqrt{n \cdot p(1-p)}$$



Seldom used, but grandfather of the following:

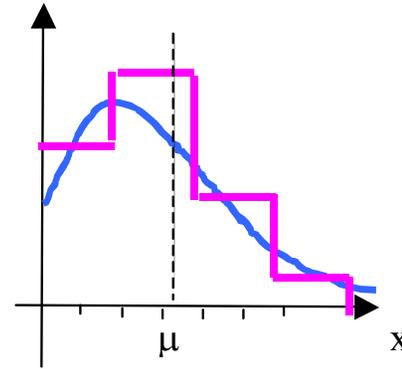
**Poisson:** follows for low  $p \ll 1$ , yet  $n \cdot p = \mu$   
 Observe  $r$  events in time interval  $t$

$$P(r, \mu) = \frac{\mu^r}{r!} e^{-\mu} = \left( \frac{(\lambda \cdot t)^r}{r!} e^{-\lambda t} \right)$$

$$\text{mean} = \lambda \cdot t = \mu$$

$$\text{st. deviation} = \sqrt{\mu}$$

Application for low rates



Intervals between two events:  $P(0, \lambda \cdot t) = e^{-\lambda \cdot t} \rightarrow t = 0$  most likely!!!!

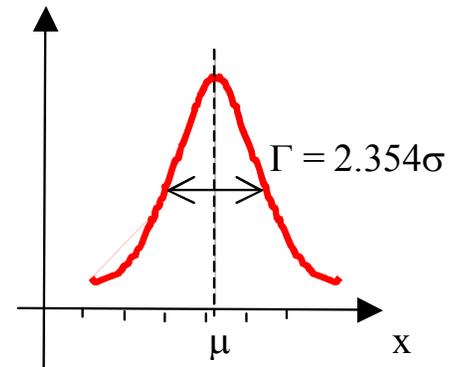
**Gaussian..** is the case for  $n \cdot p \gg 1$  (applicable to 1%, if  $np > 17$ )

$$P(x; \mu, \sigma) = \frac{1}{\sqrt{2\pi}\sigma} e^{-\frac{(x-\mu)^2}{2\sigma^2}}$$

$$\text{mean} = \mu$$

$$\text{St. deviation } \sigma = \sqrt{\mu}$$

for counting experiments



**Central Limit Theorem:**

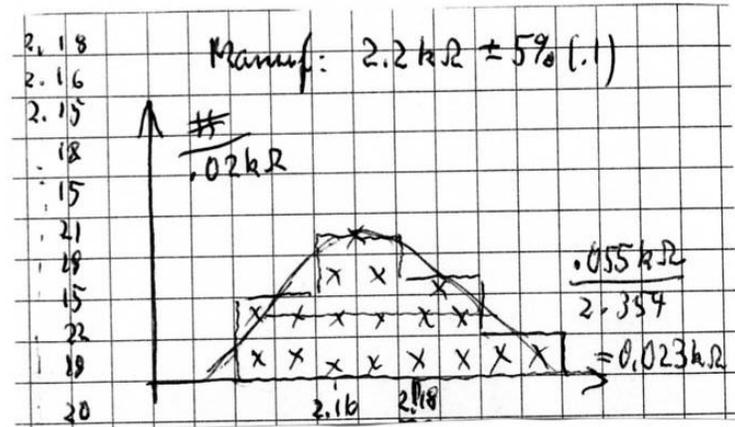
“Folding many different distributions  $\rightarrow$  always a Gaussian”.

This is the case in most of your measurements.

Distribution of 2200  $\Omega$  resistors

$$\mu = 2.17 \pm .01 \text{ k}\Omega$$

$$\sigma = 0.023 \text{ k}\Omega$$



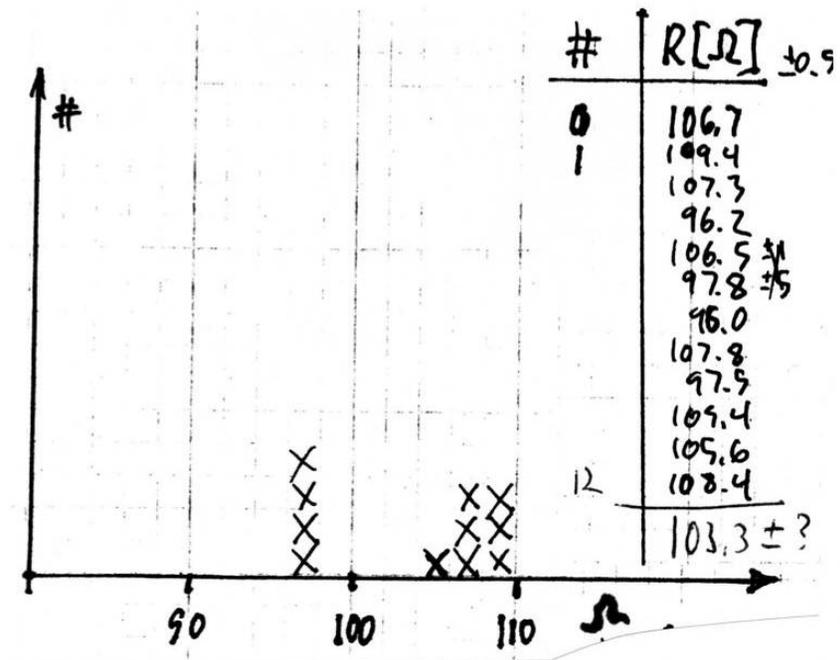
Distribution of 100  $\pm$  5  $\Omega$  resistors

$$\mu = 104 \pm \text{????}$$

No good fit !!!

$$\text{Still } \sqrt{s} = 7.5 \Omega$$

Someone selected out!!!



Given a histogram of measurements:

How do you know it is

a) A Poisson distribution?

b) Since you do not know the true mean, check the

c) Sample Variance<sup>1/2</sup>

$$\sqrt{S} = \sqrt{\frac{1}{N-1} \sum_i (x_i - \langle x \rangle)^2}$$

d) Against the standard deviation  $\sigma = \sqrt{\mu} \approx \sqrt{\langle x \rangle}$

## What does this mean?

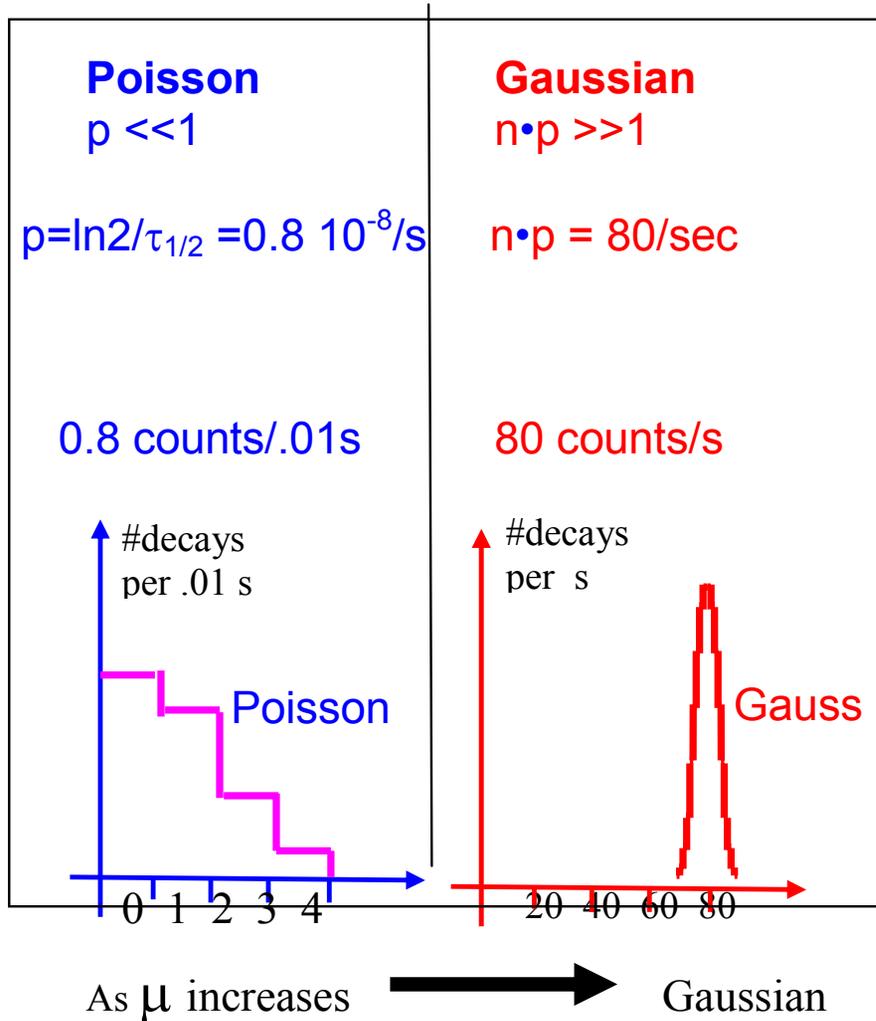
Source  $n=10^{10}$  atoms

$\text{Fe}^{55} \rightarrow \text{Mn}^{55} \gamma$

$\tau_{1/2}=2.7\text{y}=8.5 \cdot 10^7 \text{sec}$

Expected average

Decays/ Time  $=\mu= n \cdot p$



For  $\mu > 17$  Poisson  $\approx$  Gauss to 1%, Both have variance  $= \sqrt{\mu}$

Triva question: "If I make 100 of the left hand measurements and lump together in one distribution, will I see the right hand shape?" YES!!

# PROPAGATION OF ERRORS Bevington ch.3

You measure  $u \pm \sigma_u$  and  $v \pm \sigma_v$ , but evaluate  $x = u + v$  or  $x = u/v$  and want the error of  $x$ .

Taylor expansion:

$$x_i - \langle x \rangle = (u_i - \langle u \rangle) \frac{\partial x}{\partial u} + (v_i - \langle v \rangle) \frac{\partial x}{\partial v} + \dots$$

then

$$\sigma_x^2 = \lim_{N \rightarrow \infty} \frac{1}{N} \left( (u_i - \langle u \rangle) \frac{\partial x}{\partial u} + (v_i - \langle v \rangle) \frac{\partial x}{\partial v} \right)^2$$

$$= \sigma_u^2 \left( \frac{\partial x}{\partial u} \right)^2 + \sigma_v^2 \left( \frac{\partial x}{\partial v} \right)^2 + 2\sigma_{uv} \left( \frac{\partial x}{\partial u} \right) \left( \frac{\partial x}{\partial v} \right)$$

= 0 if uncorrelated, otherwise  
 $\sigma_{\mu\nu}$  covariance matrix -difficult

Sum&Diff:  $x = au + bv \quad \rightarrow \quad \sigma_x^2 = a^2 \sigma_u^2 + b^2 \sigma_v^2 \pm 2ab\sigma_{uv}$

Prod.&Div:  $x = a.uv$  or  $a.u/v \quad \rightarrow \quad \frac{\sigma_x^2}{x^2} = \frac{\sigma_u^2}{u^2} + \frac{\sigma_v^2}{v^2} + \frac{2\sigma_{uv}}{uv}$

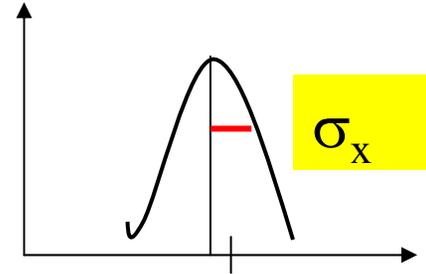
Powers:  $x = a T^4 \quad \rightarrow \quad \frac{\sigma_x}{x} = \pm 4 \frac{\sigma_T}{T} \quad \text{watch out!}$

# Famous Confusion

Make a measurement, get the mean

What is the error? **NOT  $\sigma_x$  !!!**

$$\sigma_x^2 = s_x^2 = \frac{1}{N-1} \sum_{i=1}^N (x_i - \langle x \rangle)^2$$



Best estimate = mean:  $\langle x \rangle = \frac{1}{N} \sum_{i=1}^N x_i \pm \frac{\sigma_x}{\sqrt{N}}$  error of the mean

Bevington eq 4.12

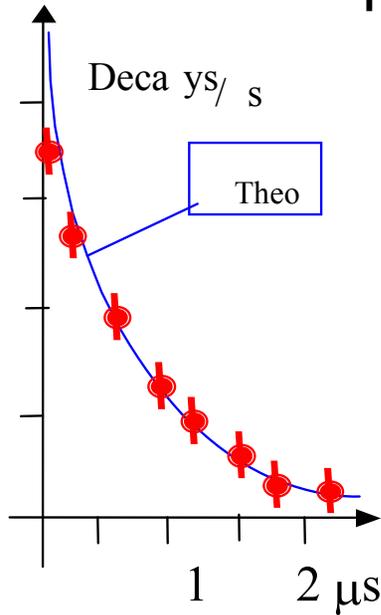
make many measurements!

If measurements  $x_i$  have different errors  $\sigma_i$

Combine:  $\langle x \rangle = \frac{\sum \frac{x_i}{\sigma_i^2}}{\sum \frac{1}{\sigma_i^2}}$  with  $\sigma = \sqrt{\frac{1}{\sum \frac{1}{\sigma_i^2}}}$

They are called: weighted average  $\pm$  combined st. dev.

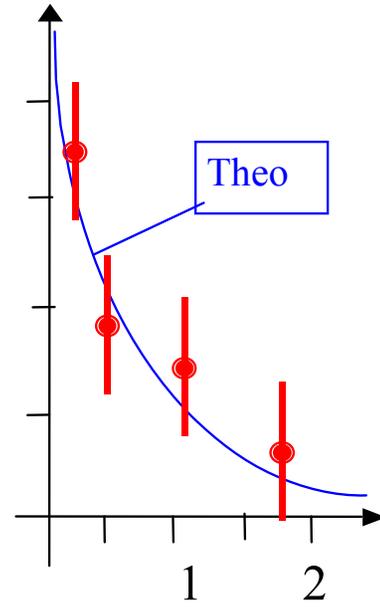
# Muon lifetime



Precise data  
but inaccurate  
T=0 value seems off  
Bad fit. Find reason  
Delete first point.

$$N(t) = (300 \pm 20_{\text{stat}} \pm 50_{\text{sys}}) \exp\{t/(2.05 \pm .03 \mu\text{s})\}$$

good



Accurate data  
but imprecise  
More data, finer  
intervals needed

$$N(t) = (330 \pm 60_{\text{stat}} \pm 10_{\text{sys}}) \exp\{t/(2.3 \pm .6 \mu\text{s})\}$$

not impressive

# The Art of fitting or the $\chi^2$ -distribution:

Bevington, ch. 4

Assume we know  $\mu_i$  the true function values in the i-th bin.

We measure n times  $x_i$  with random error  $\sigma_i$  in each bin and evaluate

$$\chi^2 = \sum_{i=1}^n \left( \frac{x_i - \mu_i}{\sigma_i} \right)^2$$

Clearly this quantity has a distribution itself, because the next random sample of n measurements will have different  $\chi^2$ .

You usually have the reverse case, the true function is not known, but approximated by

a "best fit", based on n measurements.

You want to know: "Is the fit acceptable?"

The  $\chi^2$  distribution gives you the probability that your measurement has this particular  $\chi^2$ . Define  $\chi^2 = u$  and  $v = n - \#parameters = \text{"degrees of freedom"}$ .

(With 2 data points and 2 parameters the curve must go through them, there is no "freedom to fit".)

The distribution is

$$P(u) = \frac{\left(\frac{u}{2}\right)^{v/2-1} e^{-u/2}}{2\Gamma(v/2)} \quad \text{where } \Gamma = \text{Gamma funct.}$$